Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/761,194	LAI, CHANG-CHIN		
Examiner	Art Unit		
Fahd Patel	2194		

SEARCHED			
Class	Subclass	Date	Examiner
719	331	2/7/2006	FHP
710	302	2/7/2006	FHP
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]			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		:		

SEARCH (INCLUDING SEAR)
	DATE	EXMR
EAST	2/7/2006	FHP
NPL ACM	2/13/2006	FHP
NPL IEEE	2/13/2006	FHP
Inventor Name Search	2/13/2006	FHP